

# Search Notes



Application/Control No.

10/526,717

Examiner

Lam P. Pham

Applicant(s)/Patent under Reexamination

RIETH ET AL.

Art Unit

2612

## SEARCHED

Class	Subclass	Date	Examiner
340	573.1	8/20/2007	LP
	575	//	
	576	//	
324	658	8/20/2007	LP
	660	//	
	686	//	
701	1	8/20/2007	LP
	41	//	
180	271	8/20/2007	LP
	272	//	

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
340	573.1 575, 576	8/20/2007	LP
324	658 660 686	8/20/2007	LP
701	1 41	8/20/2007	LP
180	271 272	8/20/2007	LP

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST/BRS	8/20/2007	LP
CONSULTED WITH BENJAMIN LEE	8/20/2007	LP